Influence of magnetic impurities on charge transport in diffusive-normal-metal/superconductor junctions

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Charge transport in the diffusive normal metal (DN)/insulator- s- and d-wave superconductor junctions is studied in the presence of magnetic impurities in DN in the framework of the quasiclassical Usadel equations with the generalized boundary conditions. The cases of s- and d-wave superconducting electrodes are considered. The junction conductance is calculated as a function of a bias voltage for various parameters of the DN metal, resistivity, Thouless energy, the magnetic impurity scattering rate, and the transparency of the insulating barrier between DN and a superconductor. It is shown that the proximity effect is suppressed by magnetic impurity scattering in DN for any value of the barrier transparency. In low-transparent s-wave junctions this leads to the suppression of the normalized zero-bias conductance. In contrast to that, in high transparent junctions zero-bias conductance is enhanced by magnetic impurity scattering. The physical origin of this effect is discussed. For the d-wave junctions, the dependence on the misorientation angle $\alpha$ between the normal and the crystal axis of a superconductor is studied. The zero-bias conductance peak is suppressed by magnetic impurity scattering only for low transparent junctions with $\alpha \sim 0$. In other cases the conductance of the d-wave junctions does not depend on the magnetic impurity scattering due to strong suppression of the proximity effect by the midgap Andreev resonant states.

I. INTRODUCTION

Presently, thanks to the nanofabrication technique, detailed experimental studies of the electron coherence in mesoscopic superconducting systems become possible, where the Andreev reflection plays an important role in the low energy transport. In diffusive normal metal/superconductor (DN/S) junctions, the phase coherence between incoming electrons and Andreev reflected holes persists in DN at a mesoscopic length scale and results in strong interference effects on the probability of Andreev reflection.

One of the remarkable experimental manifestations of the coherent Andreev reflection is the zero bias conductance peak (ZBCP) in DN/S junctions. The physics of ZBCP was extensively studied theoretically using scattering matrix approach and the quasiclassical Green’s function technique. Volkov, Zaitsev, and Klapwijk (VZK) explained the origin of the ZBCP in DN/S junctions in the framework of the quasiclassical theory by solving the Usadel equations with the Kupriyanov and Lukichev (KL) boundary condition for the Keldysh-Nambu Green’s function. According to the VZK theory the ZBCP is due to the enhancement of the pair amplitude in DN by the proximity effect. The influence of the magnetic impurity scattering on the bias voltage dependent conductance was also studied within this approach.

Recently the VZK theory for s-wave superconductors was extended by Tanaka et al. using more general boundary conditions provided by the circuit theory of Nazarov. These boundary conditions treat an interface as an arbitrary connector between diffusive metals. The connector is characterized by a set of transmission coefficients ranging from a ballistic point contact to a tunnel junction. The boundary conditions coincide with the KL conditions when a connector is diffusive or transmission coefficients are low, while the BTK theory is reproduced in the ballistic regime. The extended VZK theory revealed a number of new features like a U-shaped gap like structure and a crossover from a zero bias conductance peak (ZBCP) to a zero bias conductance dip (ZBCD). These phenomena are relevant for the actual junctions in which the barrier transparency is not necessarily small. However, the influence of the magnetic impurity scattering in DN on the charge transport was not studied in this regime.

The generalized VZK theory was recently applied also to unconventional superconducting junctions. The formation of the midgap Andreev resonant states (MARS) at the interface of unconventional superconductors is naturally taken into account in this approach. It was demonstrated that the formation of MARS in DN/d-wave superconductor (DN/d) junctions strongly competes with the proximity effect. Remarkable recent advances in experiments on tunneling in high $T_C$ cuprates stimulate an interest to the problem of an influence of the magnetic impurity scattering on a charge transport in DN/d junctions.

In the present paper the generalized VZK theory is applied to the study of an influence of the magnetic impurity scattering in the DN on the conductance in DN/S where S is either s- or d-wave superconductor. The parameters of the problem are the height of the insulating barrier at the DN/S interface, the resistance $R_p$, the magnetic impurity scattering rate $\gamma$, the Thouless energy $E_{Th}$ in DN and the angle $\alpha$ be-
between the normal to the interface and the crystal axis of $d$-wave superconductors. We shall focus on the dependence of the normalized conductance $\sigma_f(eV) = \sigma_f(eV)/\sigma_s(eV)$, on the bias voltage $V$, where $\sigma_S(M)(eV)$ are the conductances in the superconducting (normal) state. The organization of the paper is as follows. In Sec. II the detailed derivation of the expression for the normalized conductance is provided. In Sec. III the results of calculations of $\sigma_f(eV)$ are presented for $s$- and $d$-wave junctions separately and physical explanation of the results is given. In Sec. IV the summary of the obtained results and the conclusions are presented. In this paper we restrict ourselves to zero temperature and set $k_B = \hbar = 1$. In general the zero bias conductance (ZBC), by definition, is studied in the theory and in the experiment at $eV \to 0$. Thus, the ZBC defined in a standard way actually depends on temperature and has certain limit at $T \to 0$. On the other hand, we calculate ZBC in another way, we first set $T = 0$, then calculate the differential resistance at $eV \to 0$. We are sure that the limits $T \to 0$, $eV \to 0$ are commutable for the differential resistance.

II. FORMULATION

In this section we introduce the model and the formalism. We consider a junction consisting of normal and superconducting reservoirs connected by a quasi-one-dimensional diffusive conductor (DN) with a length $L$ much larger than the mean free path. This structure was considered in Refs. 37 and 44, while in the present paper the scattering on magnetic impurities in DN is taken into account. Similar to Ref. 37 and 44, we assume that the interface between the DN conductor and the S electrode at $x=L$ has a resistance $R_b$ while the DN/N interface at $x=0$ has zero resistance and we apply the generalized boundary conditions of Ref. 36 to treat the interface between DN and S.

We model the insulating barrier between DN and S by the delta function $U(x) = H\delta(x-L)$, which provides the transparency of the junction $T_m = 4\cos^2\phi/(4\cos^2\phi+Z^2)$, where $Z = 2H/v_F$ is a dimensionless constant, $\phi$ is the injection angle measured from the interface normal to the junction, and $v_F$ is Fermi velocity. The interface resistance $R_b$ is given by

$$R_b = R_0 \frac{2}{\int_{-\pi/2}^{\pi/2} d\phi T_m \cos \phi},$$

where $R_0$ is Sharvin resistance $R_0^s = e^2 k_F^2 S_c/4\pi^2$, $k_F$ is the Fermi wave vector and $S_c$ is the constriction area (see Fig. 1). Note that the area $S_c$ in general not equal to the cross-section area $S_d$ of the normal conductor, therefore $S_c/S_d$ is independent parameter of our theory. This allows to vary $R_b/R_0$ independently of $T_m$. In real physical situation, the assumption $S_c < S_d$ means that only a part of the actual flat DN/S interface (having area $S_c$) is conducting, no matter is it a single conducting region or a series of such regions. These conducting regions are not constrictions in a standard sense—we do not assume the narrowing of the total cross section, but rather that only the part of the cross section is conducting.

We apply the quasiclassical Keldysh formalism in the following calculation of the conductance. The definitions of $4 \times 4$ Green’s functions in DN and S, $\hat{G}_1(x)$ and $\hat{G}_2(x)$, and other notations can be found in Refs. 37 and 44. The new feature in the present model is the spin-scattering term in the static Usadel equation\(^{23}\) for $\hat{G}_1(x)$ in DN,

$$D \frac{\partial}{\partial x} \left( \hat{G}_1(x) \frac{\partial \hat{G}_1(x)}{\partial x} \right) + i[\hat{H} - i\hat{\Sigma}_{\text{spin}}, \hat{G}_1(x)] = 0,$$

where $D$ is the diffusion constant in DN, $\hat{H}$ is given by

$$\hat{H} = \begin{pmatrix} \hat{H}_0 & 0 \\ 0 & \hat{H}_0 \end{pmatrix},$$

with $\hat{H}_0 = \epsilon \hat{\tau}_3$, and

$$\hat{\Sigma}_{\text{spin}} = \frac{\gamma}{2} \hat{\tau}_3 \hat{G}_1(x) \hat{\tau}_3$$

is the self-energy for magnetic impurity scattering with the scattering rate $\gamma$ in DN. Note that magnetic impurities take random alignments and we average them in all directions, thus $\hat{G}_1(x)$ in our calculation is a unit matrix in the spin space. The Nazarov’s generalized boundary condition for $\hat{G}_1(x)$ at the DN/S interface has the same form as the one without magnetic impurity scattering (see Refs. 37 and 44).

In the actual calculation it is convenient to use the standard $\theta$-parametrization where $\theta(x)$ is a measure of the proximity effect in DN and is determined by the following equation:

$$D \frac{\partial^2}{\partial x^2} \theta(x) + 2i[\epsilon + i \gamma \cos(\theta(x))] \sin(\theta(x)) = 0.$$

One can see that introduction of magnetic impurity scattering $\gamma$ leads to modification of the effective coherence length in DN. In particular, switching on $\gamma$ makes function $\theta(x)$ exponentially decaying at zero energy, while $\theta(x)$ at $\gamma=0$ behaves linearly in DN. It will be shown below that these modifications result in suppression of $\theta$ in DN, as expected due to the pair-breaking nature of magnetic scattering, which in turn leads to corresponding modifications of the subgap conductance.
Finally, we obtain the following result for the electric current:

$$I_{el} = \frac{1}{e} \int_0^\infty \frac{de}{d\theta} \left( \frac{R_b}{I_0} + \frac{R_d}{L} \int dx \right) \cos^2 \theta_m(x)$$  \hspace{1cm} (3)

with

$$f_{\theta} = \frac{1}{2} \left[ \text{tanh}[\epsilon + \epsilon V/(2T)] - \text{tanh}[\epsilon - \epsilon V/(2T)] \right].$$

Then the total differential resistance $R$ for $s$-wave junction at zero temperature is given by

$$R = \frac{R_b}{I_0} + \frac{R_d}{L} \int dx \left( \cos^2 \theta_m(x) \right)$$  \hspace{1cm} (4)

with

$$I_{s0} = \frac{T_m}{2} \left[ (2 - T_m) \left( 1 + \cos \theta_L + \sin \theta_L \right) \right]$$

$$C_0 = T_m \left( 1 + \cos \theta_L \right) \left( \cos \theta_L + \sin \theta_L \right) \left( \cos \theta_L + \sin \theta_L \right)$$

and

$$g_s = \epsilon \sqrt{\Delta_s^2 - \epsilon^2}, \quad f_s = \Delta_s \sqrt{\Delta_s^2 - \epsilon^2}, \quad \text{and} \quad \Delta_s = \Delta \cos(2(\phi - \alpha)).$$

In the above $\alpha, \theta_m(x)$, and $\theta_L$ denote the angle between the normal to the interface and the crystal axis of $d$-wave superconductors, the imaginary part of $\theta(x)$ and $\theta(L_)$, respectively. The conductance in the superconducting state $\sigma_s(\epsilon V)$ is simply related to $R$ by $\sigma_s(\epsilon V) = 1/R$.

It is important to note that in the present approach, according to the circuit theory, $R_d/R_b$ can be varied indepen-
dentely of $T_{av}$, i.e., independently of $Z$, since one can change the magnitude of the constriction area $S_c$ independently. In other words, $R_d/R_b$ is no longer proportional to $T_{av}L/l$, where $T_{av}$ is the averaged transmissivity of the barrier and $l$ is the mean free path in the diffusive region. Based on this fact, we can choose $R_d/R_b$ and $Z$ as independent parameters.

In the following section, we will discuss the normalized conductance $\sigma_T = \sigma(\Delta)/\sigma_N(\Delta)$ where $\sigma_N(\Delta)$ is the conductance in the normal state without magnetic impurity given by $\sigma_N(\Delta) = 1/(R_d+R_b)$.

III. RESULTS

A. Tunneling conductance for s-wave junctions

In this section, we focus on the bias voltage dependent normalized conductance $\sigma_T(\Delta)$ for various situations. Let us first focus on the relatively low transparent junctions with $Z=3$ for various $\gamma/\Delta$ (Fig. 2). For $E_{Th}/\Delta=1$ and $R_d/R_b=1$, the $\sigma_T(\Delta)$ curves have a rounded bottom shape and the height of the bottom value is reduced with an increase in $\gamma/\Delta$. The height of the peak at $\Delta=\pm\Delta$ is reduced with an increase in $\gamma/\Delta$ [see Fig. 2(a)]. For $E_{Th}/\Delta=1$ and $R_d/R_b=10$, the $\sigma_T(\Delta)$ curves also have a rounded bottom structure which flattens with an increase in $\gamma/\Delta$. Also the peak at $\Delta=\pm\Delta$ is suppressed with the increase of $\gamma/\Delta$ [see Fig. 2(b)]. For small Thouless energy $E_{Th}/\Delta=0.01$ and $R_d/R_b=1$, the conductance has a prominent ZBCP with the width given by $E_{Th}$. As seen from Fig. 2(c), the magnetic impurity scattering suppresses the peak height. With the increase of the resistance ratio $R_d/R_b$, the ZBCP transforms into ZBCD, as shown in Fig. 2(d). The magnitude of ZBCD decreases with the increase of $\gamma/\Delta$, and the height of the peaks around $\Delta/\Delta = 0.04$ is also reduced [see Fig. 2(d)].

FIG. 3. Normalized conductance for $Z=1$.

FIG. 4. Normalized conductance for high transparent junctions with $Z=0$. 
seen from these figures, the characteristic energy range of \( \gamma \) which modifies the magnitude of \( \sigma_f(\epsilon) \), is determined by \( E_{\text{Th}} \), in agreement with the previous study based on the KL boundary conditions.\(^{27}\)

In the case of an intermediate barrier strength \( Z=1 \) (Fig. 3) the magnitude of \( \sigma_f(\epsilon) \) always exceeds unity. The resulting line shapes of \( \sigma_f(\epsilon) \) for \( E_{\text{Th}}/\Delta=1 \) are quite similar to the corresponding curves for \( Z=3 \) [see Figs. 3(a) and 3(b)]. For \( E_{\text{Th}}/\Delta=1 \) and \( R_d/R_b=1 \), the zero-bias value \( \sigma_f(0) \) is independent of \( \gamma/\Delta \) [see Fig. 3(a)], in contrast to the corresponding case shown in Fig. 2(a). Another important difference from the case of large \( Z \)-factor is the absence of ZBCP for low Thouless energy. It is seen that for \( E_{\text{Th}}/\Delta=0.01 \) a ZBCD occurs in both cases of \( R_d/R_b=1 \) and \( R_d/R_b=10 \). This conductance dip and the finite voltage peaks are fully suppressed with the increase of \( \gamma/\Delta \) for \( R_d/R_b=1 \) [see Fig. 3(c)]. On the other hand, for \( R_d/R_b=10 \) only the peaks around \( eV/\Delta \sim 0.04 \) are suppressed while the magnitude of \( \sigma_f(0) \) does not depend on \( \gamma \), similar to the case \( Z=3 \) [see Fig. 3(d)]. The relevant scale of \( \gamma \) is again given by the magnitude of \( E_{\text{Th}} \).

For the fully transparent case with \( Z=0 \) (Fig. 4), \( \sigma_f(\epsilon) \) also always exceeds unity. The line shapes of \( \sigma_f(\epsilon) \) with \( E_{\text{Th}}/\Delta=1 \) are similar to the corresponding curves for \( Z=3 \) and \( Z=1 \) [see Figs. 4(a) and 4(b)]. For \( E_{\text{Th}}/\Delta=1 \) and \( R_d/R_b=1 \), the magnitude of \( \sigma_f(0) \) is enhanced by \( \gamma/\Delta \) in contrast to the corresponding cases shown in Figs. 2(a) and 3(a) [see Fig. 4(a)]. For \( E_{\text{Th}}/\Delta=0.01 \) and \( R_d/R_b=1 \), \( \sigma_f(\epsilon) \) has a ZBCD. The magnitude of \( \sigma_f(0) \) is enhanced by \( \gamma/\Delta \) and the depth of the ZBCD decreases with the increase of \( \gamma/\Delta \) [see Fig. 4(c)]. On the other hand, for \( E_{\text{Th}}/\Delta=0.01 \) and \( R_d/R_b=10 \), the magnitude of \( \sigma_f(0) \) does not depend on \( \gamma \) while the finite bias peaks are suppressed similar to the cases of \( Z=3 \) and \( Z=1 \) [see Fig. 4(d)].
In order to understand the above wide variety of line shapes and their relation to the proximity effect, we shall discuss the behavior of function $\theta_L$ which is the measure of the proximity effect at the DN/S interface and determines the normalized local density of states by $\text{Re} \cos \theta_L$. At $\epsilon = 0$, $\theta_L$ is always a real number even for nonzero $\gamma$. First, we study the case of $Z = 3$ and $E_{Th}/\Delta = 1$ (Fig. 5) where the same values of $\gamma/\Delta$ and $R_d/R_B$ are chosen as in Fig. 2. The real part of $\theta_L$ has a step-function-like structure and it is always positive for $\epsilon \leq \Delta$ and negative otherwise. The absolute value of the real part of $\theta_L$ decreases with an increase in $\gamma/\Delta$. At the same time, the imaginary part of $\theta_L$ has a coherent peak, the height of which is reduced with an increase in $\gamma/\Delta$. For the case of $Z = 3$ and $E_{Th}/\Delta = 0.01$ (Fig. 6) where the same values of $\gamma/\Delta$ are chosen as in Fig. 2, the real part of $\theta_L$ has a ZBCP with the width given by $E_{Th}$. The imaginary part of $\theta_L$ has a ZBCD for $R_d/R_B = 1$. Both the amplitudes of the real and imaginary part of $\theta_L$ are reduced with the increase of $\gamma/\Delta$ only around zero energy in the interval of the order of $E_{Th}$.

Next we consider the case of $Z = 0$ with $E_{Th}/\Delta = 1$ (Fig. 7) and $E_{Th}/\Delta = 0.01$ (Fig. 8) where the same values of $\gamma/\Delta$ are chosen as in Fig. 4. The line shapes of both $\text{Re}(\theta_L)$ and $\text{Im}(\theta_L)$ are similar to those in Figs. 5 and 6. There is no clear qualitative difference between the energy dependencies of $\text{Real}[\text{Imag}](\theta_L)$ for $Z = 0$ and those for $Z = 3$. For all cases, the magnitude of $\theta_L$ is reduced with the increase of $\gamma$ and then the proximity effect is suppressed by the magnetic impurity scattering within the energy range determined by $E_{Th}$. In almost all cases, the magnitude of $\sigma_T(eV)$ is reduced with the decrease of $\theta_L$. Only for the high transparent case with not so large $R_d/R_B$, the decrease of the magnitude of $\theta_L$, i.e., the reduction of the proximity effect, can enhance the magnitude of $\sigma_T(eV)$.
In the following, we explain the wide variety of the line shapes of $\sigma_T(e\mathbb{V})$. We consider $Z=0$ and $E_{Th}/\Delta=1$ case, where $\theta_L$ has a weak energy dependence around zero voltage. For the fully transparent case with $T_m=1$, i.e., $Z=0$, $\sigma_T(0)$ can be given by

$$\sigma_T(0) = \frac{1 + R_d/R_b}{1/(I_{50}) + R_d/R_b}.$$  \tag{7}$$

with

$$\langle I_{50} \rangle = \frac{2}{1 + \sin \theta_L}.$$  \tag{8}$$

From this equation we find that the magnitude of $\sigma_T(0)$ gets close to unity under the strong proximity effect, i.e., when the magnitude of $R_d/R_b$ is large. As shown in Figs. 7(a) and 7(b), the magnitude of $\theta_L$ at $e=0$ is lowered with an increase in $\gamma/\Delta$ for $R_d/R_b=1$. Then, according to Eqs. (7) and (8), the resulting $\sigma_T(e\mathbb{V})$ around $e\mathbb{V} \sim 0$ is slightly enhanced as shown in Fig. 4(a). For $R_d/R_b=10$, the magnitude of $R_d/R_b$ is much larger than the magnitude of $1/(I_{50})$. Then the $\gamma$ dependence of $\sigma_T(0)$ becomes negligible as shown in Fig. 4(b). In order to understand the case of $Z=0$ and the small magnitude of $E_{Th}/\Delta$, we decompose $R$ into $R_1$ and $R_2$ following the previous work,\textsuperscript{37} where $R_1$ and $R_2$ are defined by

$$R_1 = \frac{1}{L} \int_0^L dx \frac{dx}{\cosh^2 \theta_m(x)}$$

and

$$R_2 = \frac{R_b}{R_d(I_{50})}.$$  \tag{9}$$

Figure 9 shows that $R_1$ has a minimum at a finite voltage which can result in a ZBCD and that $R_2$ has a maximum for high transparent junctions. For a large magnitude of $R_d/R_b$, the effect of $R_1$ is dominant, then the normalized conductance always has a ZBCD as shown in Fig. 4(c). Since $R_2$ has a maximum at zero voltage [Fig. 9(b)], the resulting $\sigma_T(e\mathbb{V})$ has a ZBCD as shown in Fig. 4(c).

Next we focus on the zero voltage resistance $R/R_b$ as a function of $R_d/R_b$. For $Z=3$, $R/R_b$ has a reentrant behavior as a function of $R_d/R_b$ due to the so-called reflectionless
tunneling effect\textsuperscript{20} [see Fig. 10(a)]. With the increase of $\gamma$, this effect is smeared since the magnitude of $\theta_s$ is reduced as shown in Fig. 11. In contrast, for $Z=0$, where $R/R_b$ increases monotonically as a function of $R_d/R_b$, the $\gamma$ dependence of $R/R_b$ is very weak [see Fig. 10(b)].

**B. Tunneling conductance for $d$-wave junctions**

Below we discuss the results of calculations for the $d$-wave case. Figure 12 shows the normalized conductance for $Z=10$, $R_d/R_b=1$, $E_{\text{Th}}/\Delta=0.01$, and $\alpha/\pi=0$ where $\alpha$ denotes the misorientation angle between the normal to the interface and the crystal axis of $d$-wave superconductors. In this case, MARS are not formed at the interface of the $d$-wave superconductor. The origin of the ZBCP is due to the proximity effect in the DN region and the height of the ZBCP is suppressed with increasing $\gamma$ similar to the case of the $s$-wave junctions.

With the increase of the magnitude of $\alpha$ the MARS are formed at the interface. The MARS contribute to the charge transport across the junction and leads to the formation of the ZBCP. As is seen in Fig. 13, the ZBCP does not depend on $\gamma$ for $Z=10$, $R_d/R_b=1$, $E_{\text{Th}}/\Delta=0.01$, and $\alpha/\pi=0.125$. The similar result is obtained for different angle $\alpha/\pi=0.25$. The reason is that MARS reduce the proximity effect in DN, therefore the influence of magnetic impurity scattering on the $\sigma_T$ becomes less important. In the extreme case, $\alpha=0.25\pi$, the proximity effect is completely absent by the symmetry of the pair potential and $\sigma_T$ is completely independent of $\gamma$.

**IV. CONCLUSIONS**

We have performed a detailed theoretical study of the conductance of diffusive normal metal/$s$- and $d$-wave superconductor junctions in the presence of magnetic impurities. Below, the main results obtained in this paper are summarized.

(1) For the $s$-wave junctions, the proximity effect is suppressed by the magnetic impurity scattering within the energy range determined by the Thouless energy in DN. In this range both the real and imaginary parts of the proximity effect parameter, i.e., Re($\theta_s$) and Im($\theta_s$) are reduced with the increase of the magnitude of $\gamma$ for any transparency of the insulating barrier.

(2) The magnitude of the normalized bias voltage dependent conductance $\sigma_T(eV)$ in the low transparent $s$-wave junctions is suppressed by the magnetic impurity scattering. On the other hand, for high transparent $s$-wave junctions, $\sigma_T(eV)$ can be enhanced by the magnetic impurity scattering.

(3) In the $d$-wave junctions, the zero bias conductance peak formed for low transparent barriers is suppressed by the magnetic impurity scattering only for $\alpha \approx 0$. For other misorientation angles the conductance is not sensitive to the magnetic impurity scattering in a diffusive normal metal.

In the present paper, we have discussed the case where magnetic impurities are located in DN. These results can be also applied to the situation when the junction is in a weak magnetic field $H$. If the field direction is parallel to the junction plane, the pair-breaking rate is given by $\gamma=e^2w^2DH^2/6$, where $w$ is the transverse size of the DN.\textsuperscript{35} Assuming $w=10^{-2}$ m, $D=10^{-2}$ m$^2$/s, $\Delta=10^{-3}$ eV, and $H=10^{-4}$–$10^{-2}$ T, we estimate the pair-breaking rate $\gamma/\Delta=10^{-3}$–$10^{-1}$. This range of $\gamma$ corresponds to the parameters chosen in the present paper. The suppression of the
ZBCP and ZBCD by the magnetic field was actually observed in several experiments. The results of the present paper may serve as a guide to study the charge transport in the junctions with magnetic impurities or under applied magnetic field.

It is also an interesting problem to study the influence of the magnetic impurity scattering on diffusive normal metal/triplet superconductor junctions where anomalous proximity effect is expected. An application of the present theory to the S/N/S junctions with unconventional superconductors also requires separate investigation.

References